Notice of References Cited Application/Control No. 10/555,664 Examiner Sun Jae Y. Loewe Applicant(s)/Patent Under Reexamination ASSAF ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	Silberg et al., caplus an 1965:88847
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